BAV756S; BAW56 series High-speed switching diodes Rev. 6 – 18 March 2015 Pr

1. **Product profile**

1.1 General description

High-speed switching diodes, encapsulated in small Surface-Mounted Device (SMD) plastic packages.

Table 1. **Product overview**

Type number	Package		Package		Configuration
	NXP	JEITA	JEDEC	configuration	
BAV756S	SOT363	SC-88	-	very small	quadruple common anode/common cathode
BAW56	SOT23	-	TO-236AB	small	dual common anode
BAW56M	SOT883	SC-101	-	leadless ultra small	dual common anode
BAW56S	SOT363	SC-88	-	very small	quadruple common anode/common anode
BAW56T	SOT416	SC-75	-	ultra small	dual common anode
BAW56W	SOT323	SC-70	-	very small	dual common anode

1.2 Features and benefits

- High switching speed: $t_{rr} \le 4$ ns
- Low leakage current
- Small SMD plastic packages

1.3 Applications

- High-speed switching
- General-purpose switching

1.4 Quick reference data

Table 2. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per diode	·						
I _R	reverse current	V _R = 80 V		-	-	0.5	μA
V _R	reverse voltage			-	-	90	V
t _{rr}	reverse recovery time		[1]	-	-	4	ns

[1] When switched from I_F = 10 mA to I_R = 10 mA; R_L = 100 Ω ; measured at I_R = 1 mA.



- Low capacitance: $C_d \le 2 \text{ pF}$
- Reverse voltage: $V_R \le 90 V$
- AEC-Q101 qualified

High-speed switching diodes

2. Pinning information

Pin	Description	Simplified outline	Symbol
BAV756S			
1	anode (diode 1)		
2	cathode (diode 2)		6 5 4
3	common anode (diode 2 and diode 3)	0	
4	cathode (diode 3)		
5	anode (diode 4)		1 2 3
6	common cathode (diode 1 and diode 4)		006aab103
BAW56; BA	AW56T; BAW56W	I	
1	cathode (diode 1)		
2	cathode (diode 2)	3	3
3	common anode	1 2 006aaa144	1 2 006aab099
BAW56M			
1	cathode (diode 1)		
2	cathode (diode 2)		3
3	common anode	2 Transparent top view	1 2 006aab099
BAW56S			
1	cathode (diode 1)		
2	cathode (diode 2)		6 5 4
3	common anode (diode 3 and diode 4)	0	
4	cathode (diode 3)		
5	cathode (diode 4)		1 2 3
6	common anode (diode 1 and diode 2)		006aab102

2 of 16

High-speed switching diodes

3. Ordering information

Type number	Package						
	Name Description		Version				
BAV756S	SC-88	plastic surface-mounted package; 6 leads	SOT363				
BAW56	-	plastic surface-mounted package; 3 leads	SOT23				
BAW56M	SC-101	leadless ultra small plastic package; 3 solder lands; body 1.0 \times 0.6 \times 0.5 mm	SOT883				
BAW56S	SC-88	plastic surface-mounted package; 6 leads	SOT363				
BAW56T	SC-75	plastic surface-mounted package; 3 leads	SOT416				
BAW56W	SC-70	plastic surface-mounted package; 3 leads	SOT323				

4. Marking

Table 5. Marking codes

Type number	Marking code ^[1]
BAV756S	A7*
BAW56	A1*
BAW56M	S5
BAW56S	A1*
BAW56T	A1
BAW56W	A1*

[1] * = -: made in Hong Kong

* = p: made in Hong Kong

- * = t: made in Malaysia
- * = W: made in China

5. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per diode					
V _{RRM}	repetitive peak reverse voltage		-	90	V
V _R	reverse voltage		-	90	V
I _F	forward current				
	BAV756S	T _s = 60 °C	-	250	mA
	BAW56	$T_{amb} \le 25 \ ^{\circ}C$	-	215	mA
	BAW56M	$T_{amb} \le 25 \ ^{\circ}C$	-	150	mA
	BAW56S	T _s = 60 °C	-	250	mA
	BAW56T	T _s = 90 °C	-	150	mA
	BAW56W	$T_{amb} \le 25 \ ^{\circ}C$	-	150	mA

High-speed switching diodes

Symbol	Parameter	Conditions	Min	Max	Unit
I _{FRM}	repetitive peak forward current		-	500	mA
I _{FSM}	non-repetitive peak forward	square wave [1]			
	current	t _p = 1 μs	-	4	А
		t _p = 1 ms	-	1	А
		t _p = 1 s	-	0.5	А
P _{tot}	total power dissipation	[2]			
	BAV756S	T _s = 60 °C	-	350	mW
	BAW56	$T_{amb} \le 25 \ ^{\circ}C$	-	250	mW
	BAW56M	$T_{amb} \le 25 \ ^{\circ}C$ [3]	-	250	mW
	BAW56S	T _s = 60 °C	-	350	mW
	BAW56T	T _s = 90 °C [4]	-	170	mW
	BAW56W	$T_{amb} \le 25 \ ^{\circ}C$	-	200	mW
Per device)				
l _F	forward current				
	BAV756S	T _s = 60 °C	-	100	mA
	BAW56	$T_{amb} \le 25 \ ^{\circ}C$	-	125	mA
	BAW56M	$T_{amb} \leq 25 \ ^{\circ}C$	-	75	mA
	BAW56S	T _s = 60 °C	-	100	mA
	BAW56T	T _s = 90 °C	-	75	mA
	BAW56W	$T_{amb} \le 25 \ ^{\circ}C$	-	130	mA
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

Table 6. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

[1] $T_j = 25 \ ^\circ C$ prior to surge.

- [2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.
- [3] Reflow soldering is the only recommended soldering method.
- [4] Single diode loaded.

6. Thermal characteristics

Table 7.Thermal characteristicsSymbolParameterCondit

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per diode							
ung a)	thermal resistance from junction to ambient	in free air	<u>[1]</u>				
	BAW56			-	-	500	K/W
	BAW56M		[2]	-	-	500	K/W
	BAW56W			-	-	625	K/W

High-speed switching diodes

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-sp)}	thermal resistance from junction to solder point					
	BAV756S		-	-	255	K/W
	BAW56		-	-	360	K/W
	BAW56S		-	-	255	K/W
	BAW56T		-	-	350	K/W
	BAW56W		-	-	300	K/W

 Table 7.
 Thermal characteristics ...continued

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Reflow soldering is the only recommended soldering method.

7. Characteristics

Table 8.Characteristics

 $T_{amb} = 25 \ ^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diode	l					
V _F	forward voltage	[1]				
		I _F = 1 mA	-	-	715	mV
		I _F = 10 mA	-	-	855	mV
		I _F = 50 mA	-	-	1	V
		I _F = 150 mA	-	-	1.25	V
I _R	reverse current	V _R = 25 V	-	-	30	nA
		V _R = 80 V	-	-	0.5	μΑ
		V _R = 25 V; T _j = 150 °C	-	-	30	μΑ
		V _R = 80 V; T _j = 150 °C	-	-	150	μΑ
C _d	diode capacitance	V _R = 0 V; f = 1 MHz	-	-	2	pF
t _{rr}	reverse recovery time	[2]	-	-	4	ns
V _{FR}	forward recovery voltage	[3]	-	-	1.75	V

[1] Pulse test: $t_p \le 300 \ \mu s$; $\delta \le 0.02$.

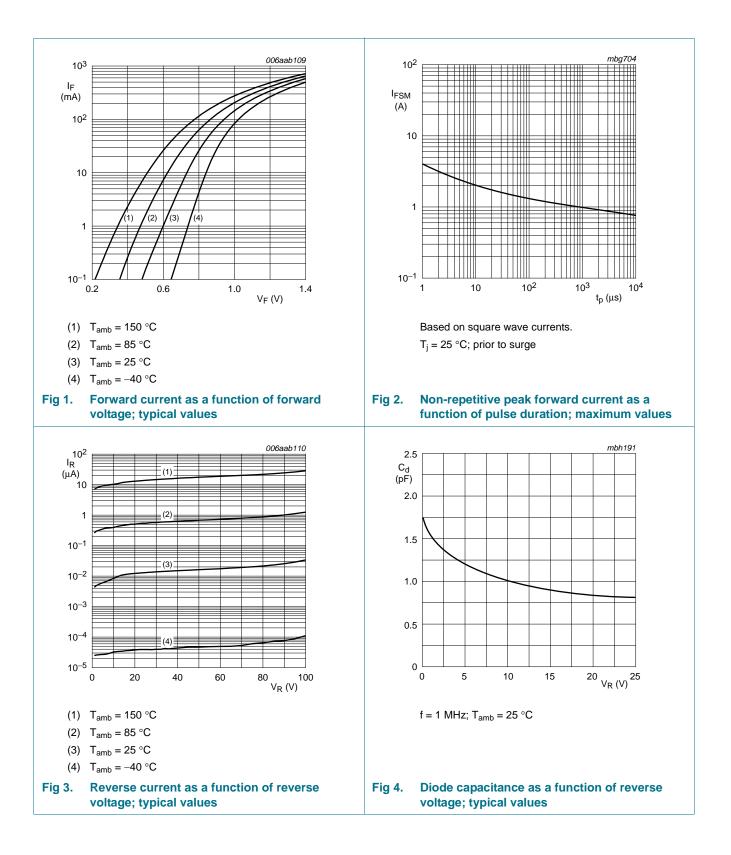
[2] When switched from I_F = 10 mA to I_R = 10 mA; R_L = 100 $\Omega;$ measured at I_R = 1 mA.

[3] When switched from $I_F = 10 \text{ mA}$; $t_r = 20 \text{ ns}$.

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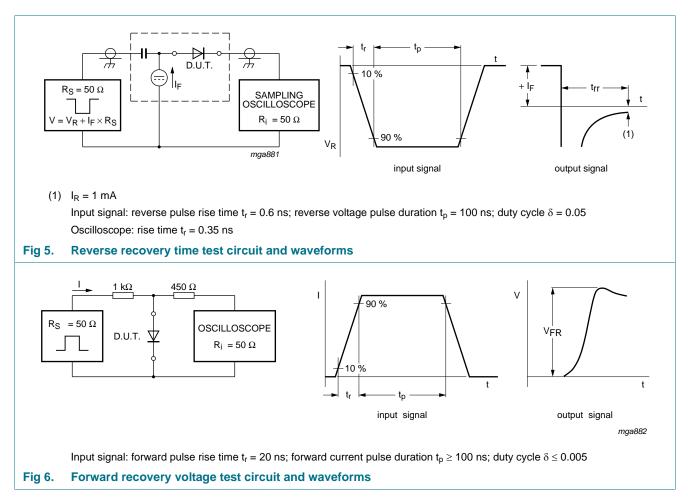
BAV756S; BAW56 series

High-speed switching diodes



High-speed switching diodes

8. Test information

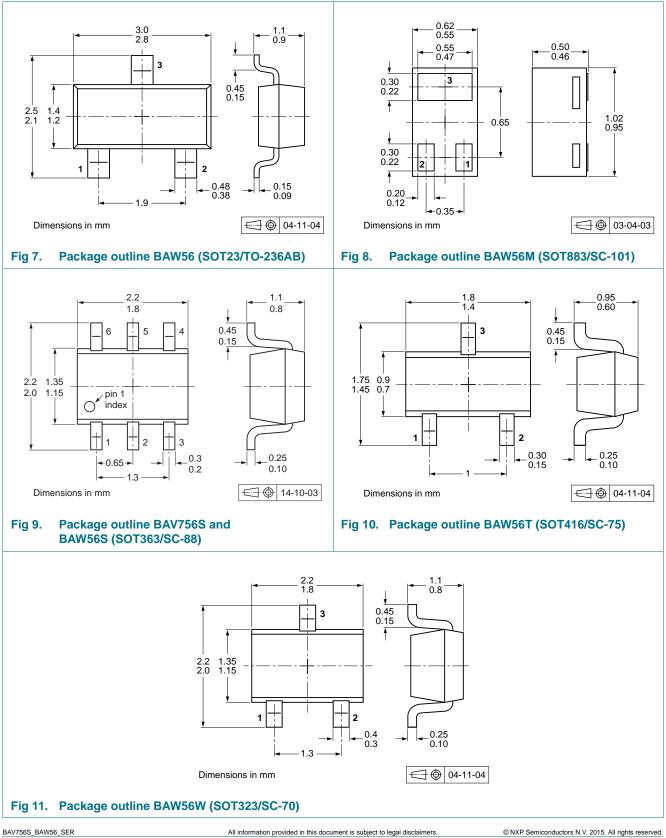


8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

High-speed switching diodes

9. Package outline



High-speed switching diodes

10. Packing information

Table 9. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

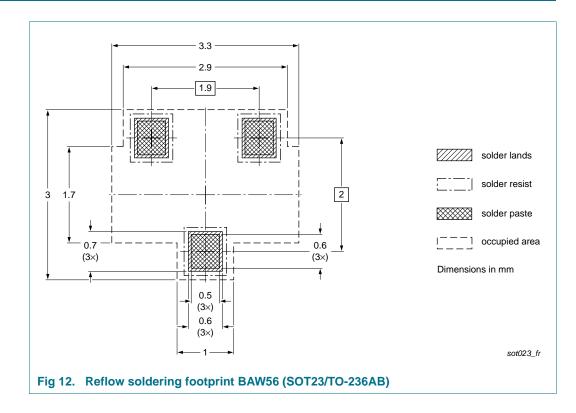
Type number	Type number Package Description		Packing quantity	
			3000	10000
BAV756S	SOT363	4 mm pitch, 8 mm tape and reel; T1 [2]	-115	-135
		4 mm pitch, 8 mm tape and reel; T2 3	-125	-165
BAW56	SOT23	4 mm pitch, 8 mm tape and reel	-215	-235
BAW56M	SOT883	2 mm pitch, 8 mm tape and reel	-	-315
BAW56S	SOT363	4 mm pitch, 8 mm tape and reel; T1 [2]	-115	-135
		4 mm pitch, 8 mm tape and reel; T2 [3]	-125	-165
BAW56T	SOT416	4 mm pitch, 8 mm tape and reel	-115	-135
BAW56W	SOT323	4 mm pitch, 8 mm tape and reel	-115	-135

[1] For further information and the availability of packing methods, see <u>Section 14</u>.

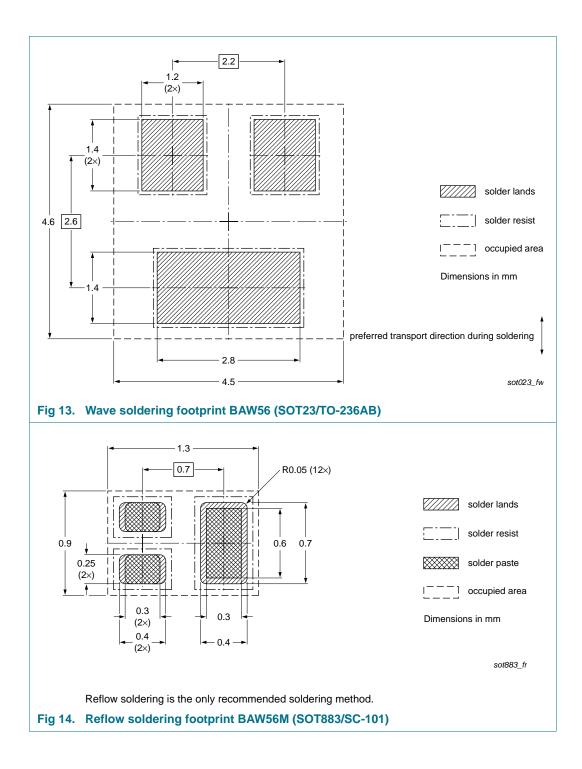
[2] T1: normal taping

[3] T2: reverse taping

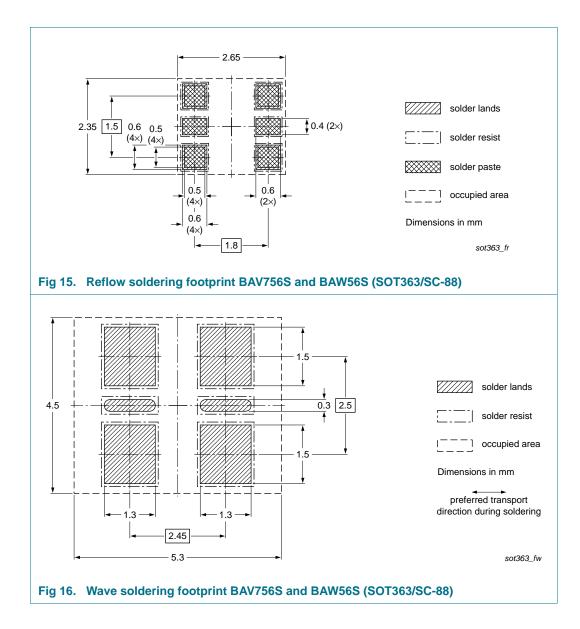
11. Soldering



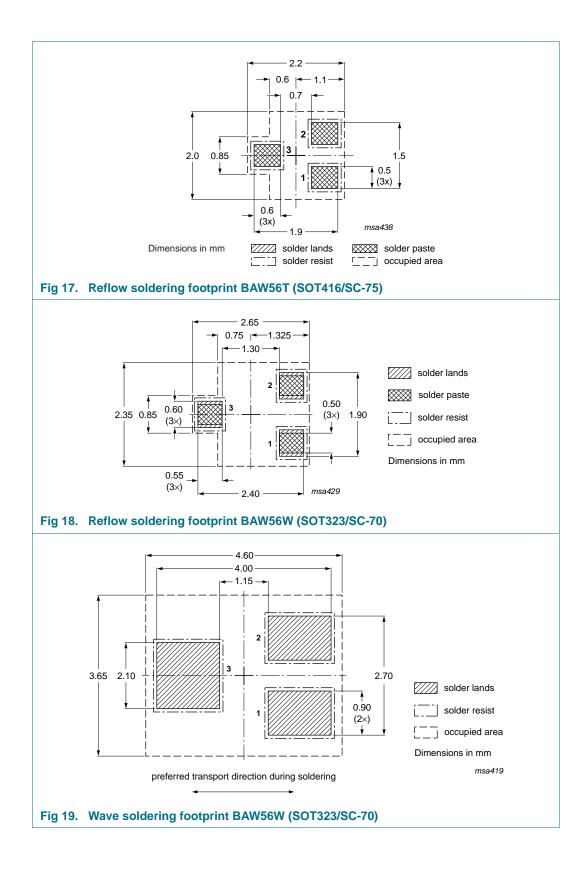
High-speed switching diodes



High-speed switching diodes



High-speed switching diodes



High-speed switching diodes

12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BAV756S_BAW56_SER v.6	20150318	Product data sheet	-	BAV756S_BAW56_SER_ 5
Modifications:		this data sheet has been red	lesigned to comply v	vith the new identity
	 Legal texts have 	ave been adapted to the new	company name whe	ere appropriate.
BAV756S_BAW56_SER_5	20071126	Product data sheet	-	BAV756S_2 BAW56_4 BAW56S_2 BAW56T_2 BAW56W_4
BAV756S_2	19971021	Product specification	-	BAV756S_1
BAW56_4	20030325	Product specification	-	BAW56_3
BAW56S_2	19971021	Product specification	-	BAW56S_1
BAW56T_2	19971219	Product specification	-	-
BAW56W_4	19990511	Product specification	-	BAW56W_3

Table 10. Revision history

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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High-speed switching diodes

15. Contents

1	Product profile 1
1.1	General description 1
1.2	Features and benefits 1
1.3	Applications 1
1.4	Quick reference data 1
2	Pinning information 2
3	Ordering information 3
4	Marking 3
5	Limiting values 3
6	Thermal characteristics 4
7	Characteristics 5
8	Test information 7
8.1	Quality information 7
9	Package outline 8
10	Packing information 9
11	Soldering 9
12	Revision history 13
13	Legal information 14
13.1	Data sheet status 14
13.2	Definitions 14
13.3	Disclaimers
13.4	Trademarks 15
14	Contact information 15
15	Contents 16

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